

# **FMR11N90E**

#### **FUJI POWER MOSFET**

# Super FAP-E<sup>3</sup> series

### **N-CHANNEL SILICON POWER MOSFET**

#### Features

Maintains both low power loss and low noise Lower R<sub>DS</sub>(on) characteristic More controllable switching dv/dt by gate resistance

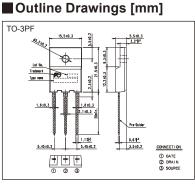
Smaller V<sub>GS</sub> ringing waveform during switching Narrow band of the gate threshold voltage (4.0±0.5V) High avalanche durability

#### Applications

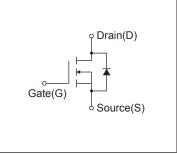
Switching regulators UPS (Uninterruptible Power Supply) **DC-DC** converters

#### Maximum Ratings and Characteristics

#### Absolute Maximum Ratings at Tc=25°C (unless otherwise specified)



Equivalent circuit schematic



Description	Symbol	Characteristics	Unit	Remarks
Durain Secures Voltage	VDS	900	V	
Drain-Source Voltage	VDSX	900	V	V <sub>GS</sub> = -30V
Continuous Drain Current	lo	±11	А	
Pulsed Drain Current	IDP	±44	А	
Gate-Source Voltage	Vgs	±30	V	
Repetitive and Non-Repetitive Maximum AvalancheCurrent	lar	11	А	Note*1
Non-Repetitive Maximum Avalanche Energy	Eas	811.9	mJ	Note*2
Repetitive Maximum Avalanche Energy	Ear	13.5	mJ	Note*3
Peak Diode Recovery dV/dt	dV/dt	2.2	kV/µs	Note*4
Peak Diode Recovery -di/dt	-di/dt	100	A/µs	Note*5
Verview Perver Dissinction	PD	3.13	W	Ta=25°C
Maximum Power Dissipation		135	VV	Tc=25°C
Oneverting and Stevens Temperature vense	Tch	150	°C	
Operating and Storage Temperature range	Tstg	-55 to + 150	°C	

#### Electrical Characteristics at Tc=25°C (unless otherwise specified)

Description	Symbol	Conditions		min.	typ.	max.	Unit	
Drain-Source Breakdown Voltage	BVDSS	I <sub>D</sub> =250µA, V <sub>GS</sub> =0V		900	-	-	V	
Gate Threshold Voltage	Vgs (th)	ID=250µA, VDS=VGS		3.5	4.0	4.5	V	
Zero Gate Voltage Drain Current		V <sub>DS</sub> =900V, V <sub>GS</sub> =0V	T <sub>ch</sub> =25°C	-	-	25		
	IDSS	V <sub>DS</sub> =720V, V <sub>GS</sub> =0V	T <sub>ch</sub> =125°C	-	-	250	- μΑ	
Gate-Source Leakage Current	Igss	V <sub>GS</sub> =±30V, V <sub>DS</sub> =0V		-	10	100	nA	
Drain-Source On-State Resistance	RDS (on)	ID=5.5A, VGS=10V	I <sub>D</sub> =5.5A, V <sub>GS</sub> =10V		0.83	1.0	Ω	
Forward Transconductance	g <sub>fs</sub>	ID=5.5A, VDS=25V		6.5	13	-	S	
Input Capacitance	Ciss	V <sub>DS</sub> =25V	V <sub>DS</sub> =25V V <sub>GS</sub> =0V		2300	3450	pF	
Output Capacitance	Coss	V <sub>GS</sub> =0V			200	300		
Reverse Transfer Capacitance	Crss	f=1MHz		-	15	22.5		
Turn-On Time	td(on)	V <sub>cc</sub> =600V V <sub>cs</sub> =10V I <sub>D</sub> =5.5A R <sub>6</sub> =20Ω		-	37	56	ns	
	tr			-	32	48		
Turn-Off Time	td(off)			-	124	186		
	tf			-	34	51		
Total Gate Charge	QG	1501		-	60	90		
Gate-Source Charge	QGS	— V∞=450V — I₀=11A — V₀s=10V		-	17	26	nC	
Gate-Drain Charge	QGD			-	23	35		
Gate-Drain Crossover Charge	Qsw			-	7	11		
Avalanche Capability	lav	L=4.92mH, T <sub>ch</sub> =25°C		11	-	-	A	
Diode Forward On-Voltage	Vsd	IF=11A, VGS=0V, Tch=25°C		-	0.90	1.35	V	
Reverse Recovery Time	trr	I <sub>F</sub> =11A, V <sub>GS</sub> =0V		-	2.0	-	μS	
Reverse Recovery Charge	Qrr	-di/dt=100A/µs, Tch=25°C		-	20	-	μC	

#### • Thermal Characteristics

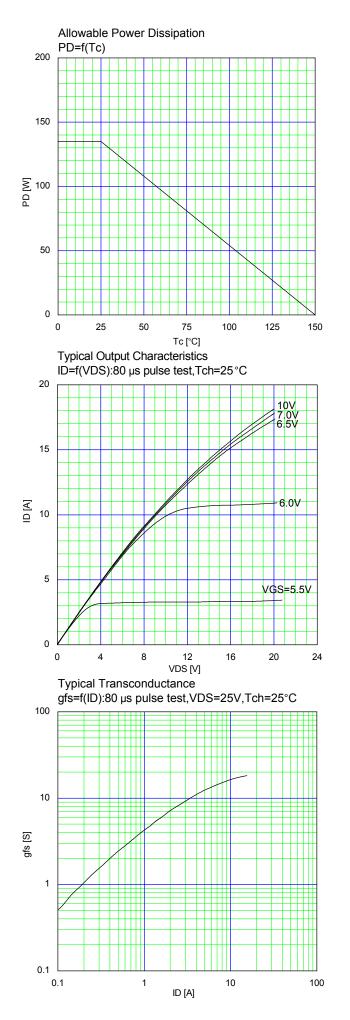
Description	Symbol	Test Conditions	min.	typ.	max.	Unit
Thermal resistance	Rth (ch-c)	Channel to case			0.9259	°C/W
	Rth (ch-a)	Channel to ambient			40.0	°C/W

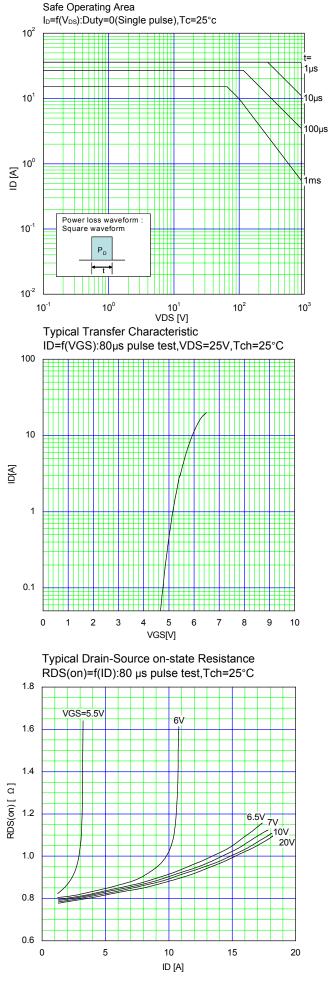
#### Note \*1 : Tch≤150°C

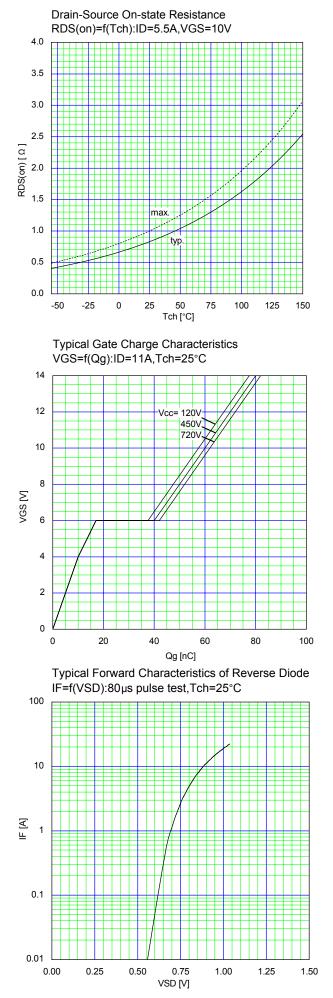
Note \*2 : Stating Tch=25°C, IAs=4.4A, L=76.9mH, Vcc=90V, RG=10Ω EAs limited by maximum channel temperature and avalanche current. See to 'Avalanche current' graph.

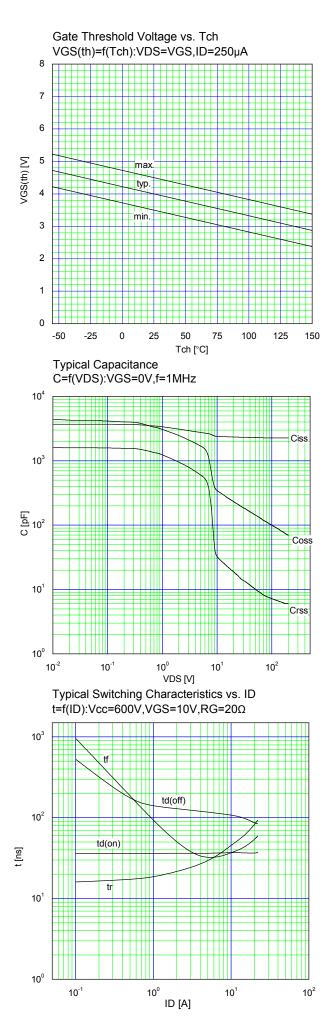
Note \*3 : Repetitive rating : Pulse width limited by maximum channel temperature

See to the 'Transient Themal impeadance' graph. Note \*4 : IFS-ID, -di/dt=100A/µs, VccSBVoss, TchS150°C. Note \*5 : IFS-ID, dv/dt=2.2kV/µs, VccSBVoss, TchS150°C.

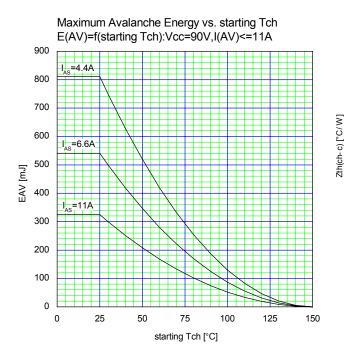




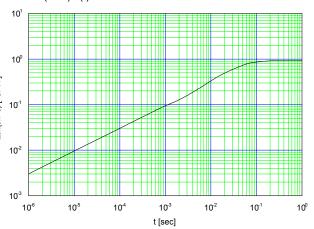




3



Transient Thermal Impedance Zth(ch-c)=f(t):D=0



## WARNING

		WARNING		
The contents are sub		teristics, data, materials, and structure ecification changes or other reasons. V		
express or implied, un Technology Co., Ltd. warranty, whether exp	nder any patent, copyright, trade se is (or shall be deemed) granted. Fu	se of Fuji's products for your reference cret or other intellectual property right ji Electric Device Technology Co., Ltd. ngement or alleged infringement of oth ein.	owned by Fuji Electric Device makes no representation or	ich
products may become adequate safety measure	e faulty. When using Fuji Electric se sures to prevent the equipment fror	nancing product quality and reliability, a miconductor products in your equipme n causing a physical injury, fire, or othe ail-safe, flame retardant, and free of m	ent, you are requested to take er problem if any of the products	tor
4. The products introduc normal reliability requ	0	use in the following electronic and electronic	ctrical equipment which has	
Computers	OA equipment	Communications equipment (terr	ninal devices)	Measurement equipment
<ul> <li>Machine tools</li> </ul>	<ul> <li>Audiovisual equipment</li> </ul>	<ul> <li>Electrical home appliances</li> </ul>	<ul> <li>Personal equipment</li> </ul>	<ul> <li>Industrial robots etc.</li> </ul>
below, it is imperative such equipment, take product incorporated • Transportation equip • Traffic-signal contro	e to contact Fuji Electric Device Tecc adequate measures such as a bac in the equipment becomes faulty. pment (mounted on cars and ships) al equipment		al. When using these products for rom malfunctioning even if a Fuji's nications equipment letectors with an auto-shut-off feat	
<ul> <li>6. Do not use products i equipment (without lin</li> <li>Space equipment</li> <li>Submarine repeater</li> </ul>	mitation). • Aeronautic equipmer	quiring strict reliability such as the follo t • Nuclear control equip		
	8 by Fuji Electric Device Technolog g may be reproduced in any form o	y Co., Ltd. All rights reserved. r by any means without the express pe	rmission of Fuji Electric Device	
using the product. Neither Fuji Electric D		g, ask Fuji Electric Device Technology agents shall be liable for any injury cau		